

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10541906	FINCH ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Barker, Matthew	3662

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
342	157.2,194,	12/21/2006	Hien Le
342	163,159-164	8/9/2007	Hien Ly
342	160	6/12/2008	MMB
	updated	1/2/2009	MMB
	updated	8/21/2009	MMB

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Inventor's name search	12/20/2006	Hien Ly
NPL search	12/20/2006	Hien Ly
Plus search	12/20/2006	Hien Ly
Text search	12/20/2006	Hien ly
NPL search (update)	8/8/2007	Hien ly
Text search (update)	8/8/2007	Hien Ly
342/104, 105, 109, 115, 194, 195, 161, 162, 164 - test search, see printoutx	6/12/2008	MMB
EAST text search - see printout	6/13/2008	MMB
Updated text search - see printout	1/2/2009	MMB
Updated text search - see printout	8/21/2009	MMB

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>